## Notice of References Cited Application/Control No. 10/710,819 Examiner Jacob K. Ackun Jr. Applicant(s)/Patent Under Reexamination CHANG ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,336,851	01-2002	Shendon, Norm	451/303
	В	US-6,095,900	08-2000	Fruitman et al.	451/28
	С	US-6,390,891	05-2002	Guha et al.	451/41
	D	US-5,931,719	08-1999	Nagahara et al.	451/41
	ш	US-2004/0072502	04-2004	Taylor, Theodore M.	451/028
	F	US-2003/0110609	06-2003	Taylor, Theodore M.	29/402.03
	G	US-2003/0228836	12-2003	Lombardo et al.	451/533
	Н	US-			
	1	US-			
	J	US-			
	K	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
	0					
	Р					
	Q					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	J	
	<b>&gt;</b>	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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